

Power Semiconductors for Power Electronics Applications
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Grid Systems R&D, Power Systems
ABB Switzerland Ltd, Semiconductors

CAS-PSI Special course

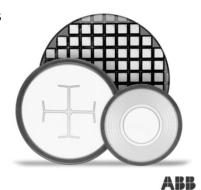
Power Converters, Baden Switzerland, 8th May 2014

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Power and productivity for a better world **

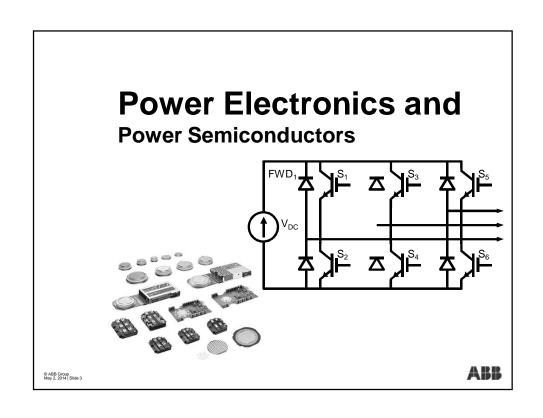
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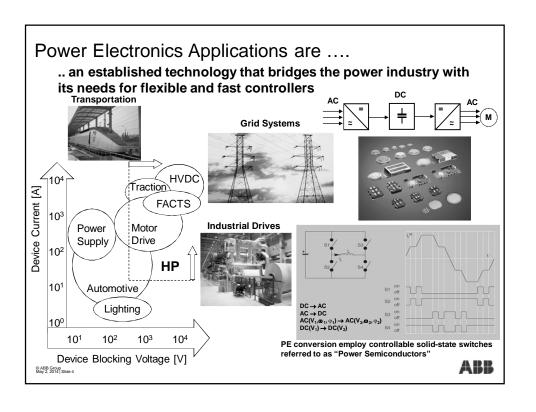
- Power Electronics and Power Semiconductors
- Understanding the Basics
- Technologies and Performance
- Packaging Concepts
- Technology Drivers and Trends
- Wide Band gap Technologies
- Conclusions

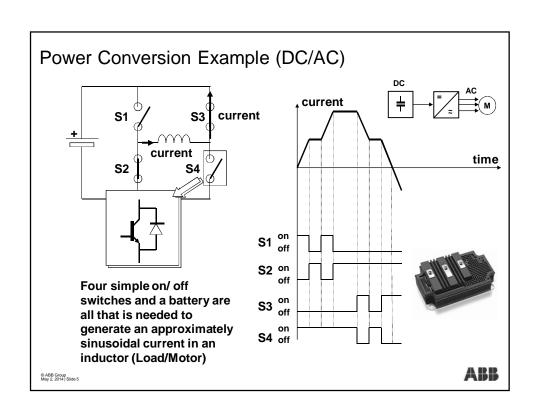


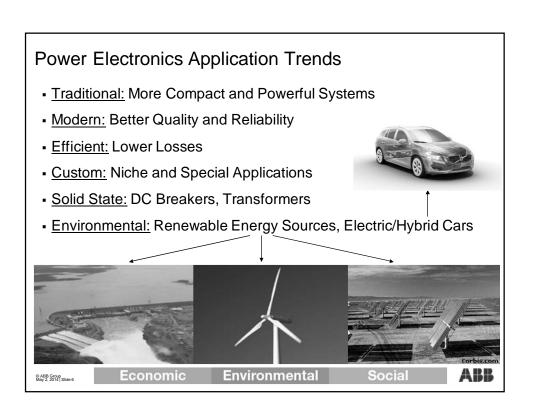
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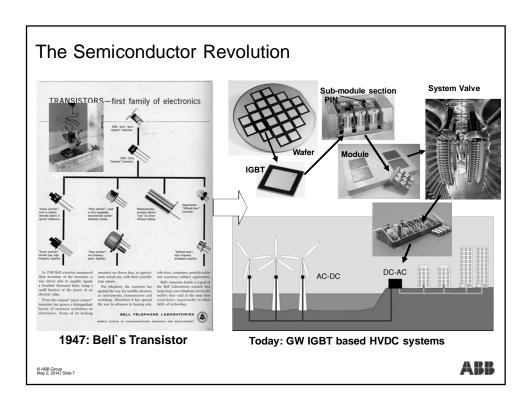
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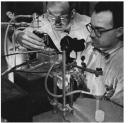


Semiconductors, Towards Higher Speeds & Power

- It took close to two decades after the invention of the solid-state bipolar transistor (1947) for semiconductors to hit mainstream applications
- The beginnings of power semiconductors came at a similar time with the integrated circuit in the fifties
- Both lead to the modern era of advanced DATA and POWER processing
- While the main target for ICs is increasing the speed of data processing, for power devices it was the controlled power handling capability
- Since the 1970s, power semiconductors have benefited from advanced Silicon material and technologies/ processes developed for the much larger and well funded IC applications and markets

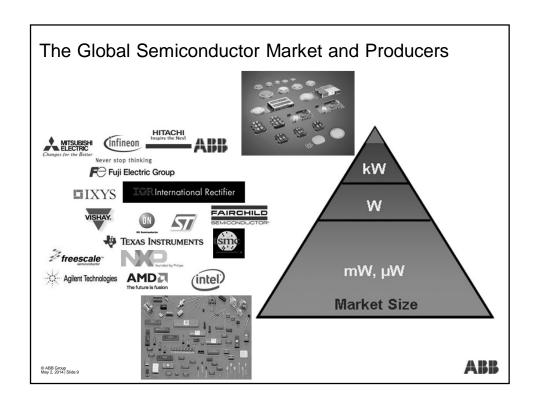


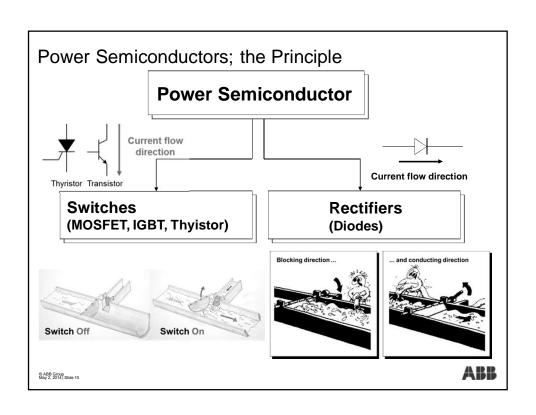
Kilby's first IC in 1958

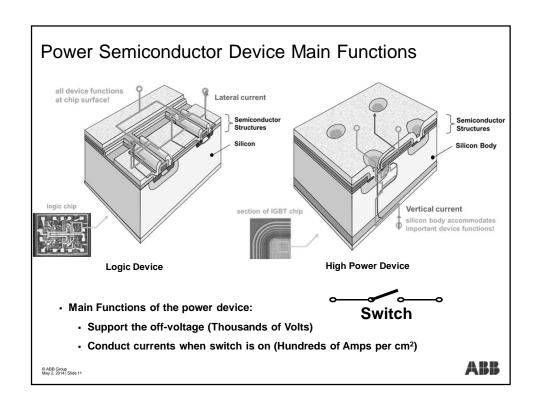


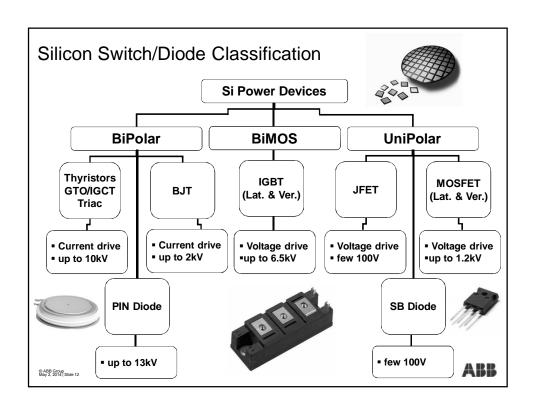
Robert N. Hall (left) at GE demonstrated the first 200V/35A Ge power diode in 1952

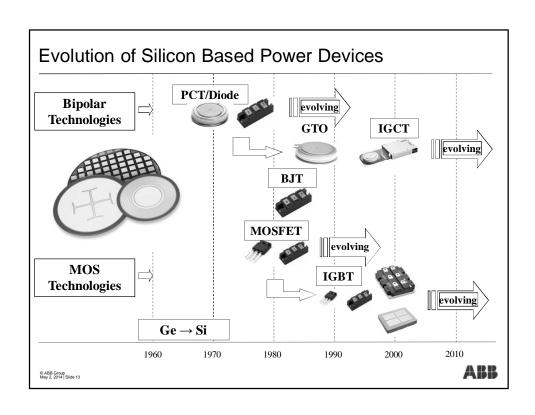
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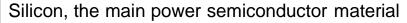






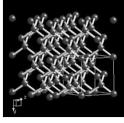








- Silicon is the second most common chemical element in the crust of the earth (27.7% vs. 46.6% of Oxygen)
- Stones and sand are mostly consisting of Silicon and Oxygen (SiO₂)
- For Semiconductors, we need an almost perfect Silicon crystal
- Silicon crystals for semiconductor applications are probably the best organized structures on earth



 Before the fabrication of chips, the semiconductor wafer is doped with minute amounts of foreign atoms (p "B, Al" or n "P, As" type doping)





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Power Semiconductor Processes



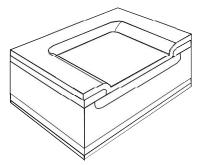
- It takes basically the same technologies to manufacture power semiconductors like modern logic devices like microprocessors
- But the challenges are different in terms of Device Physics and Application

Device	Critical Dimension	Min. doping concentration	Max. Process Temperature*	
Logic Devices	0.1 - 0.2 μm	10 ¹⁵ cm ⁻³	1050 - 1100°C (minutes)	
MOSFET, IGBT	1 - 2 μm	10 ¹³ - 10 ¹⁴ cm ⁻³	1250°C (hours)	
Thyristor, GTO, IGCT	10 -20 μm	< 10 ¹³ cm ⁻³	1280-1300°C(days) melts at 1360°C	

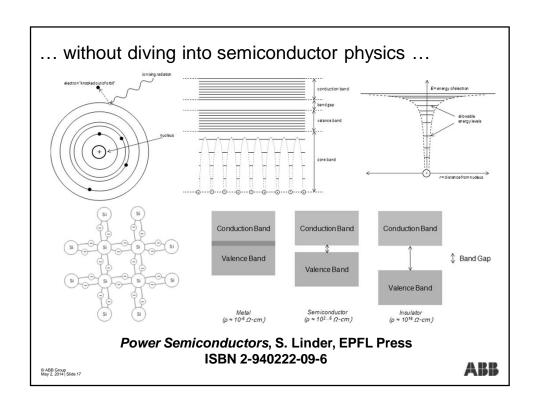
- Doping and thickness of the silicon must be tightly controlled (both in % range)
- Because silicon is a resistor, device thickness must be kept at absolute minimum
- Virtually no defects or contamination with foreign atoms are permitted

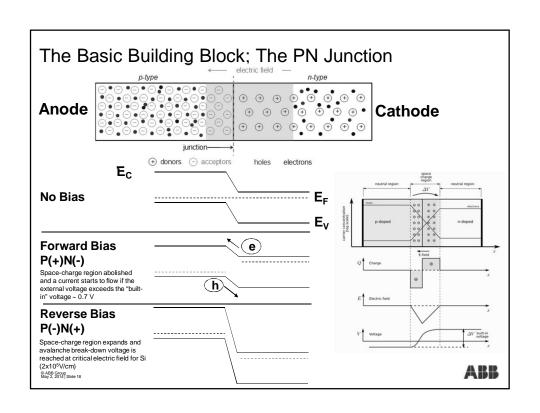
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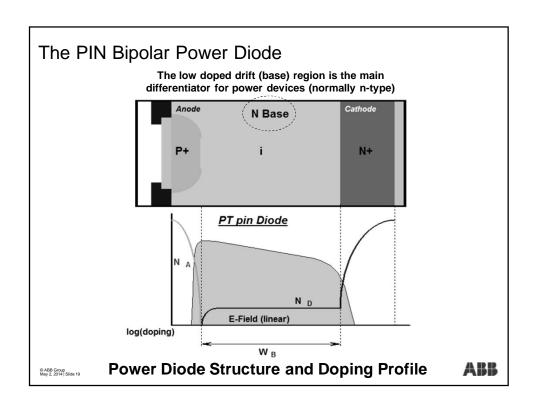
Power Semiconductors Understanding The Basics

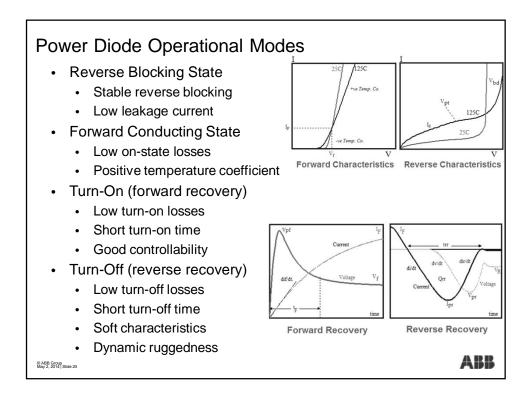


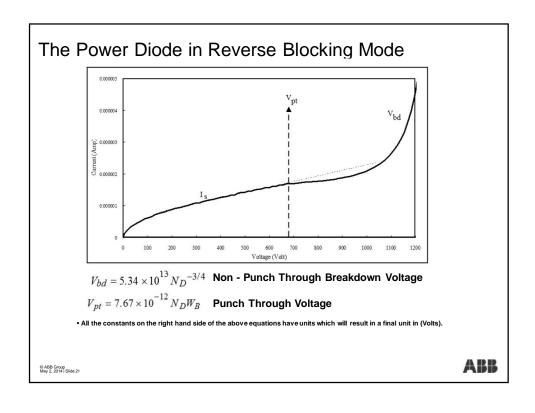
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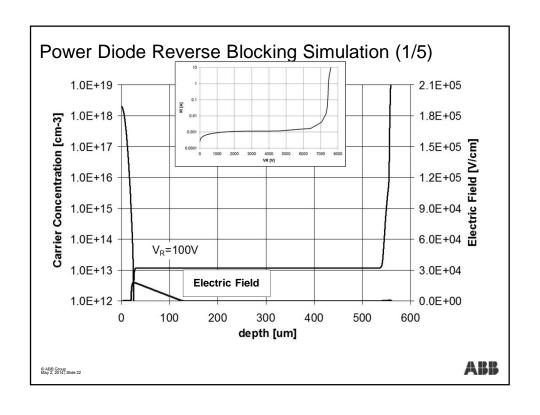


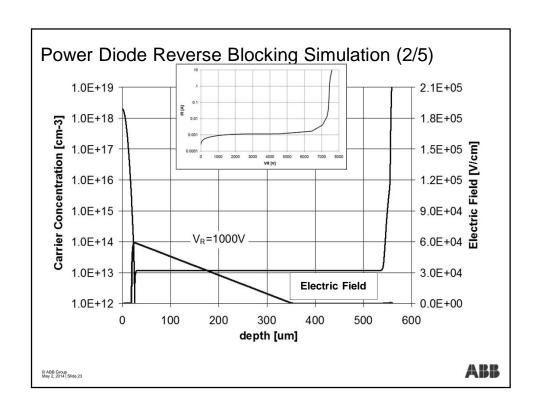


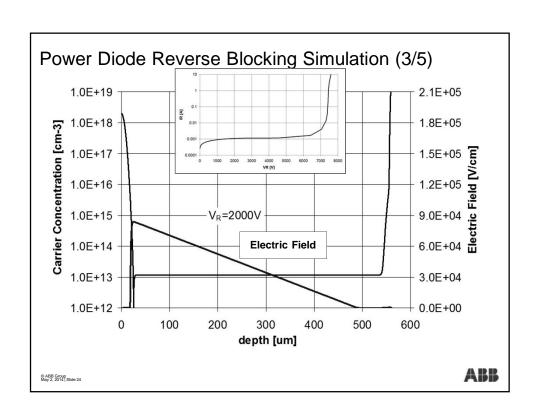


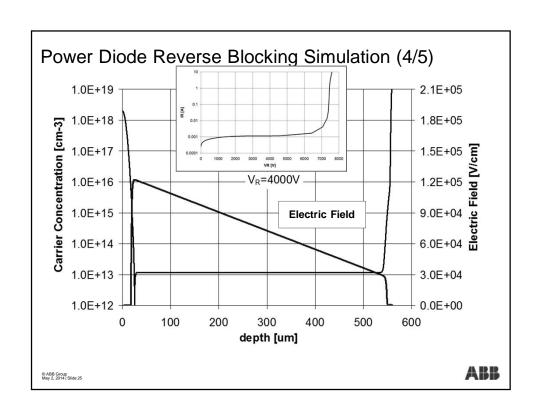


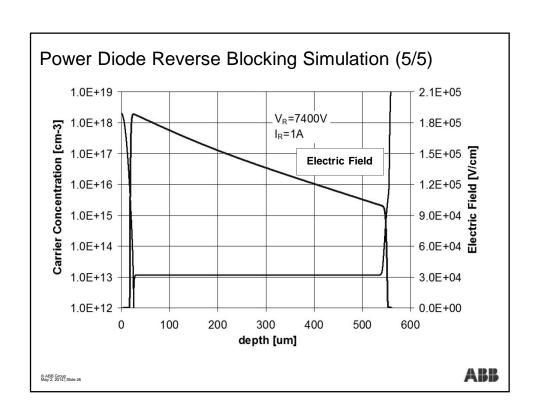


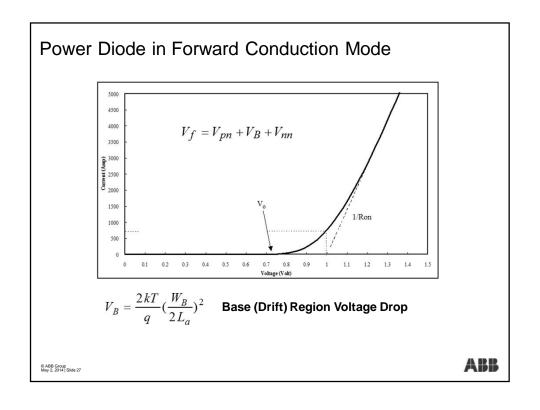


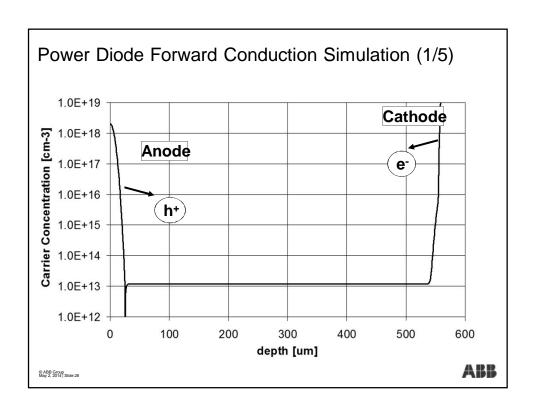


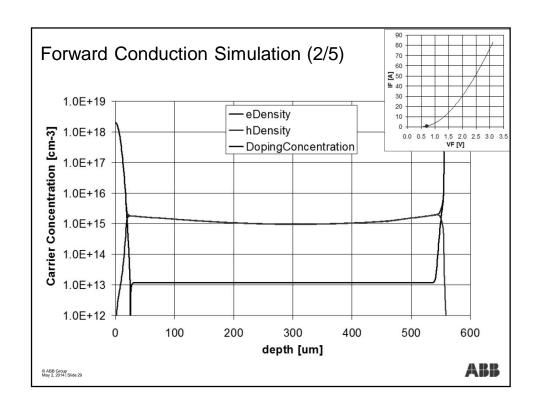


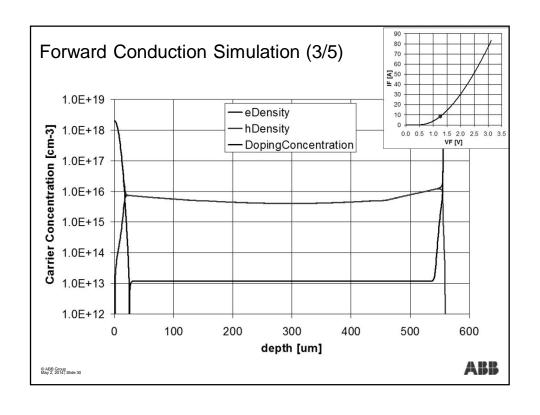


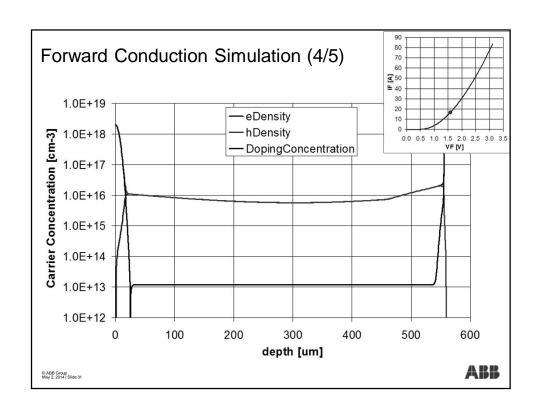


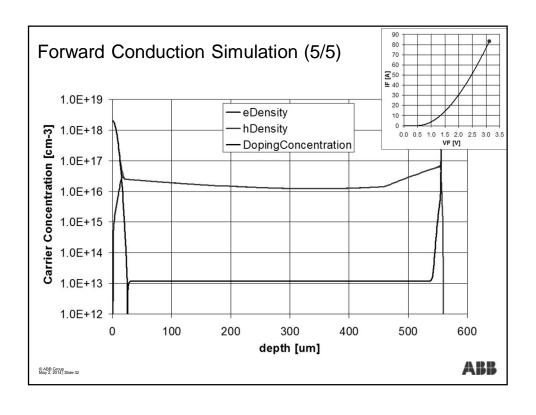


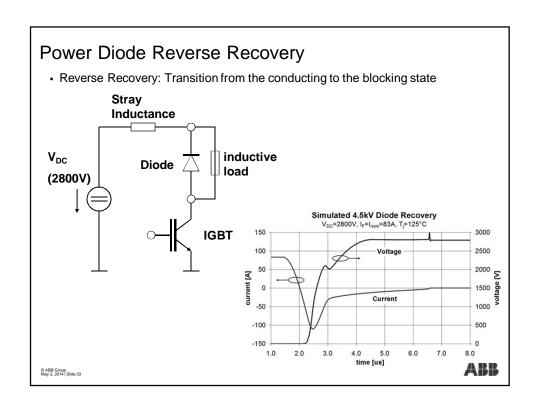


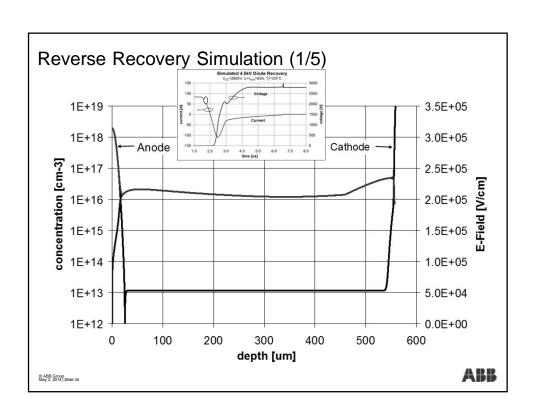


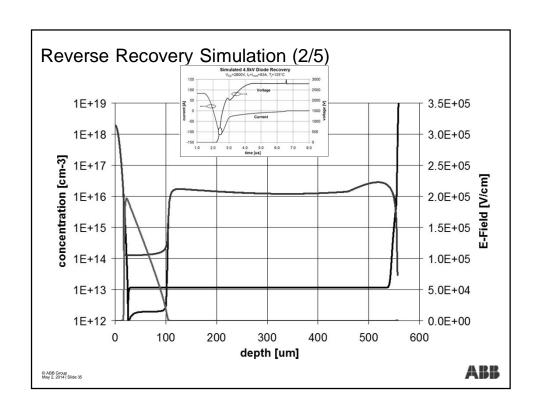


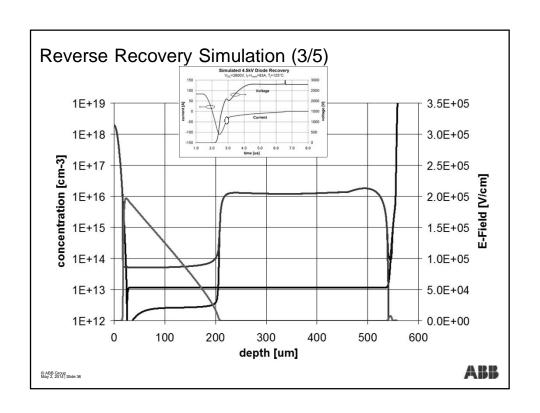


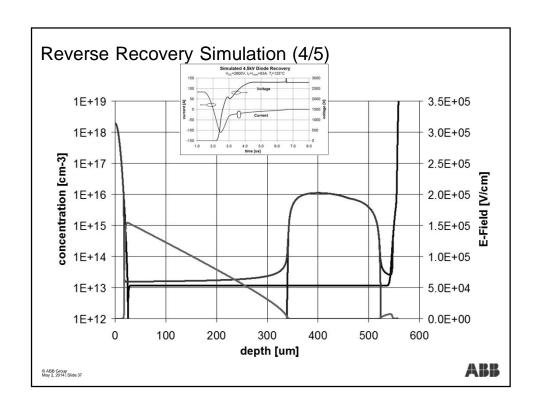


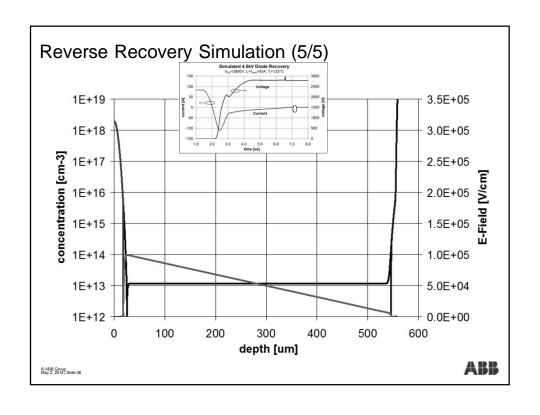




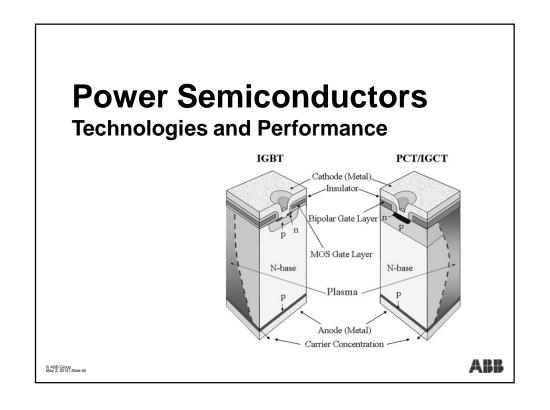


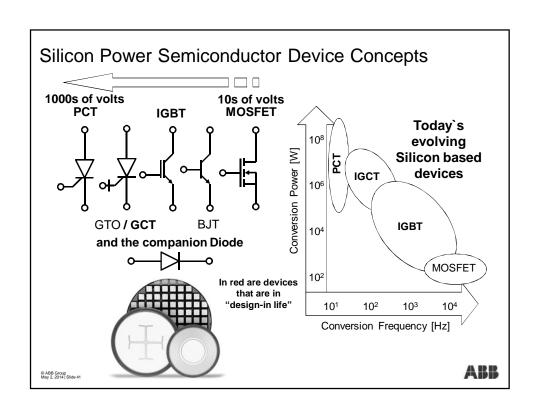






Lifetime Engineering of Power Diodes • Recombination Lifetime: Average value of time (ns - us) after which free carriers recombine (= disappear). Lifetime Control: Controlled introduction of lattice defects → enhanced carrier recombination -> shaping of the carrier distribution Example of carrier recombination in Silicon: **ON-state Carrier Distribution** CONCENTRATION without lifetime control **VP**-/0 with local lifetime control Simulated 4.5kV Diode Recovery V_{DC}=2800V, I_F=I_{nom}=83A, T_j=125°C DEPTH 50 -50 -100 -150 -200 -250 ABB © ABB Group May 2, 2014 | Slide 39





Technology	Device Character	Control Type
Bipolar (Thyristor) Thyristor, GTO, GCT	Low on-state losses High Turn-off losses	Current Controlled ("High" control power)
Bipolar (Transistor) BJT, Darlington	Medium on-state losses Medium Turn-off losses	Current Controlled ("High" control power)
BiMOS (Transistor)	Medium on-state losses Medium Turn-off losses	Voltage Controlled (Low control power)
Unipolar (Transistor) MOSFET, JFET	High on-state losses Low Turn-off losses	Voltage Controlled (Low control power)

Performance Requirements for Power Devices

- Power Density Handling Capability:
 - Low on-state and switching losses
 - High operating temperatures
 - · Low thermal resistance

Controllable and Soft Switching:

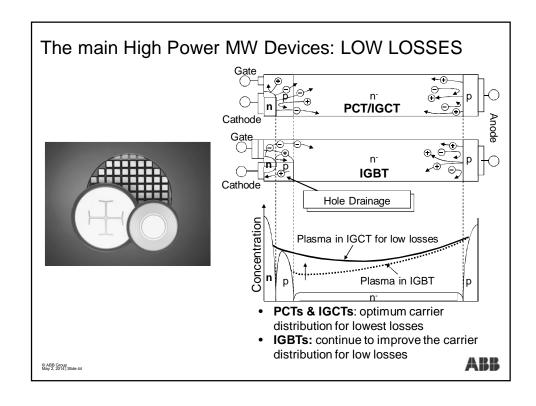
- Good turn-on controllability
- · Soft and controllable turn-off and low EMI

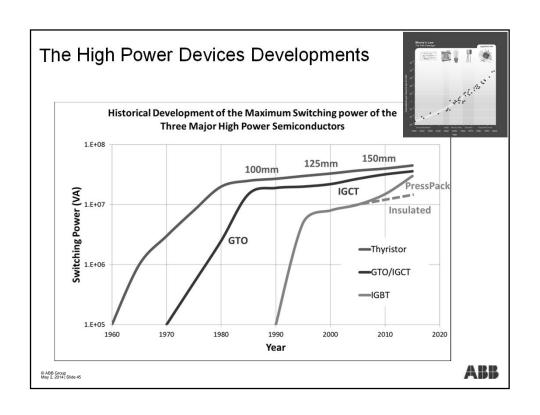
Ruggedness and Reliability:

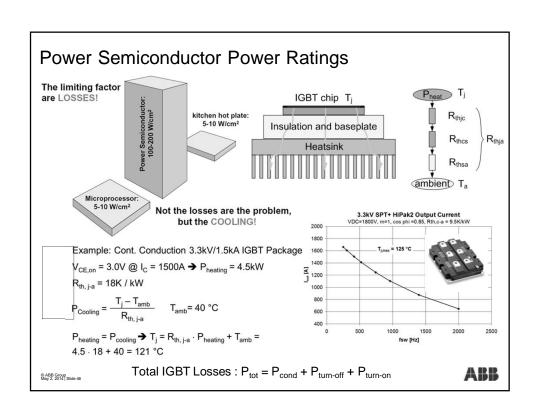
- High turn-off current capability
- · Robust short circuit mode for IGBTs
- Good surge current capability
- Good current / voltage sharing for paralleled / series devices
- · Stable blocking behaviour and low leakage current
- Low "Failure In Time" FIT rates
- Compact, powerful and reliable packaging

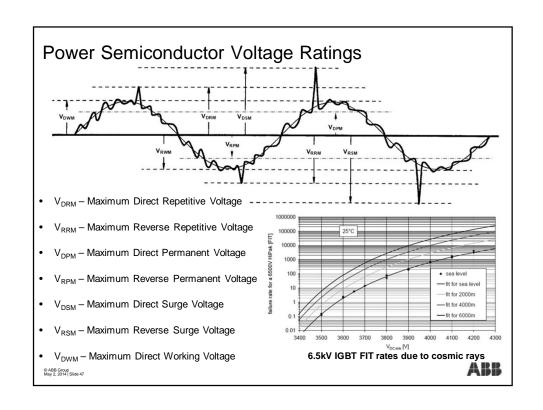
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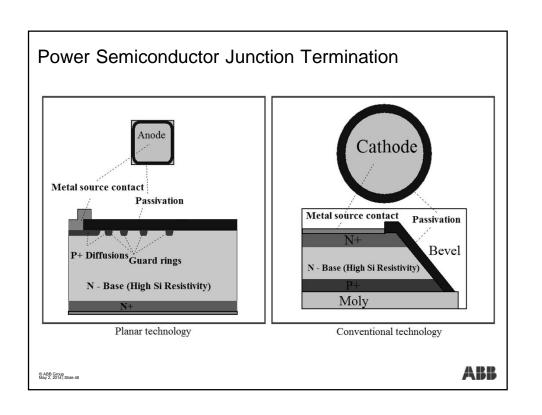
(technology curve: traditional focus)

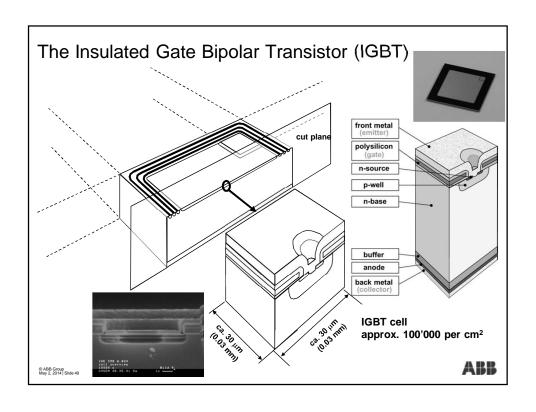


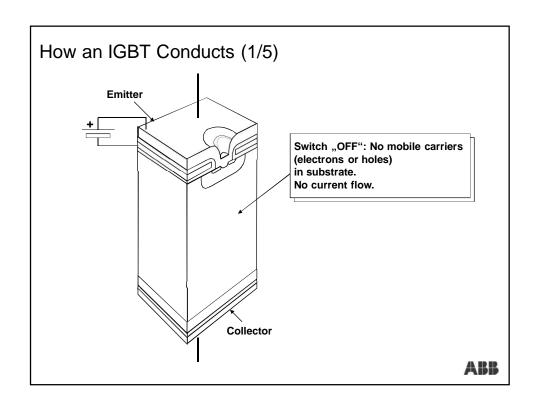


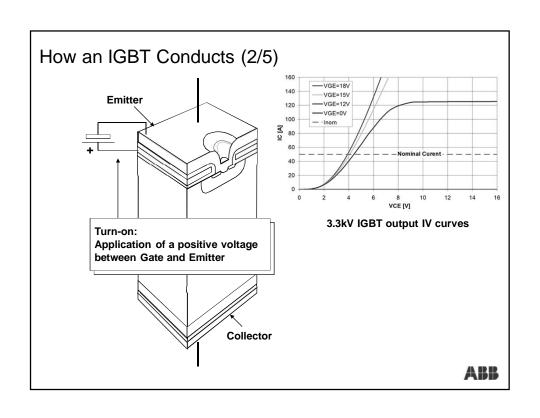


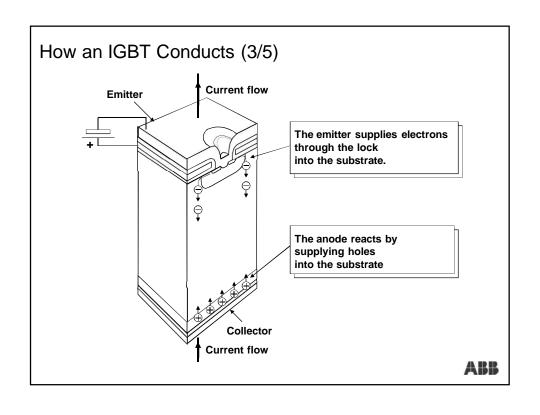


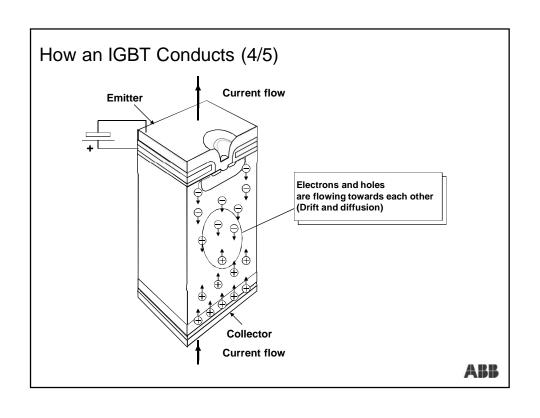


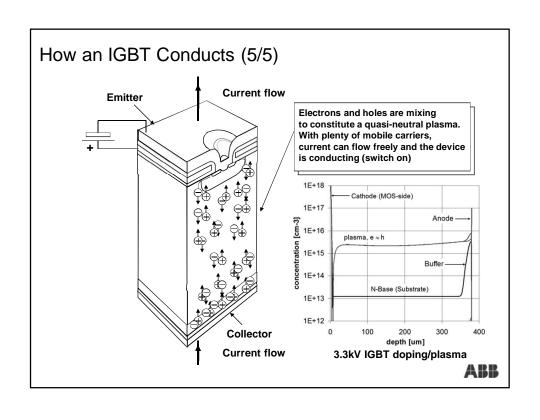


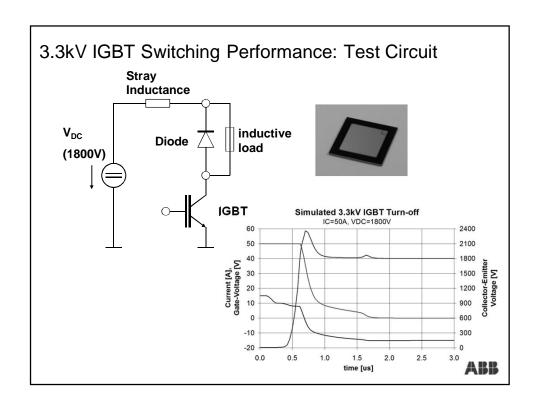


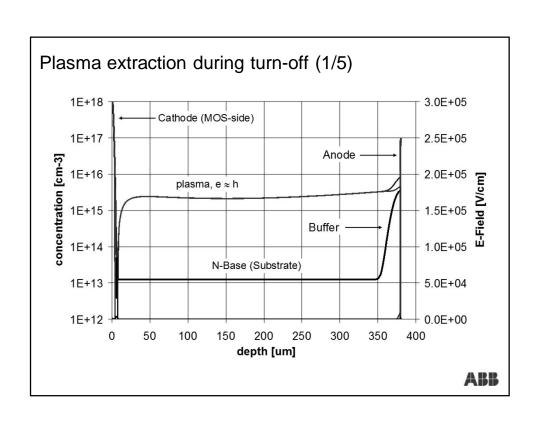


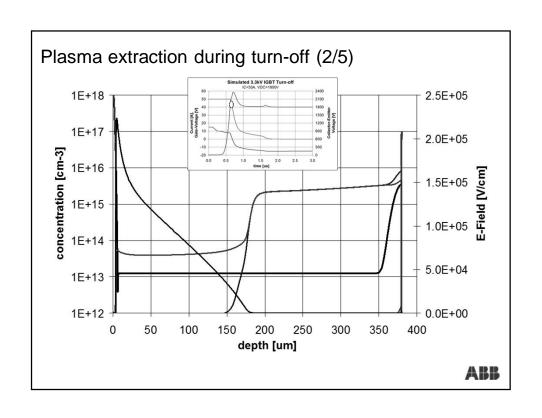


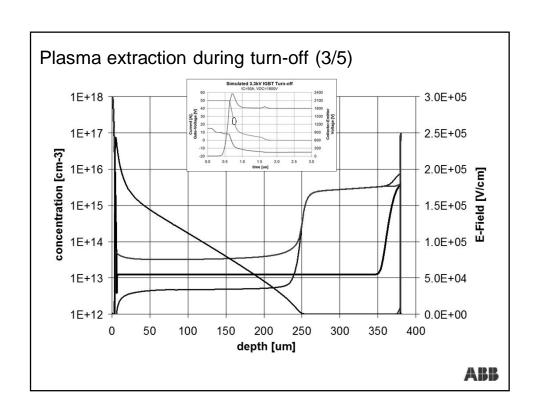


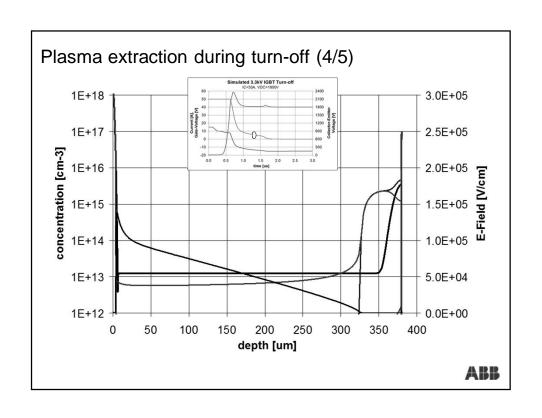


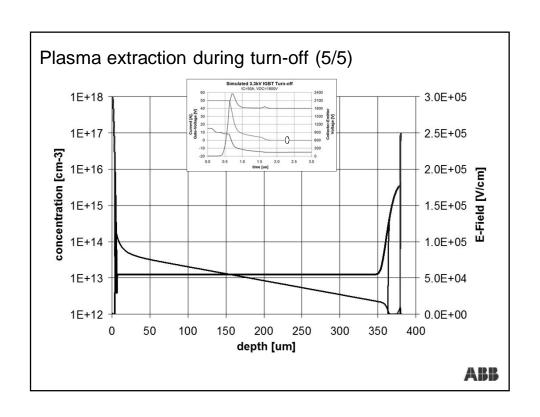


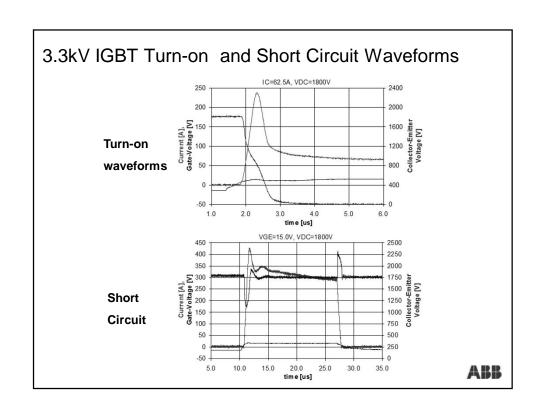


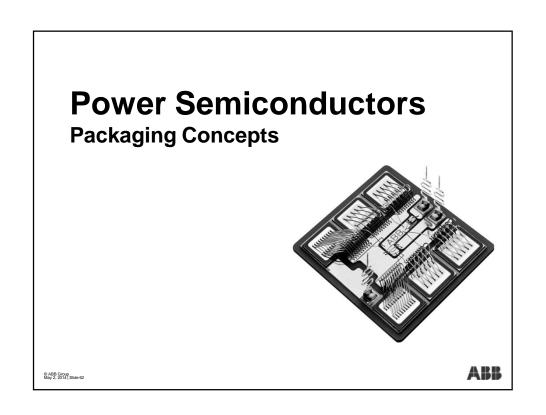












Power Semiconductor Device Packaging

- What is Packaging?
- A package is an enclosure for a single element, an integrated circuit or a hybrid circuit. It provides hermetic or non-hermetic protection, determines the form factor, and serves as the <u>first</u> <u>level interconnection externally</u> for the device by means of package terminals. [Electronic Materials Handbook]
- Package functions in PE

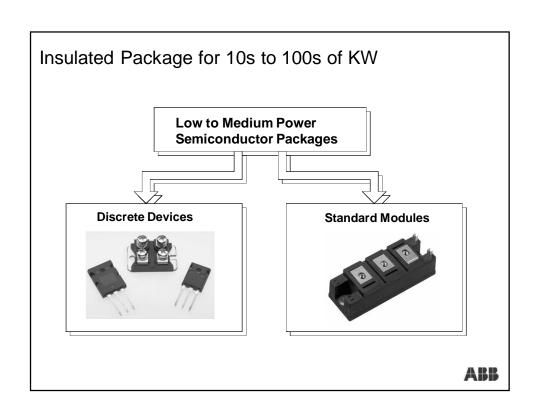
 Power and Signal distribution
 Heat dissipation
 HV insulation
 Protection

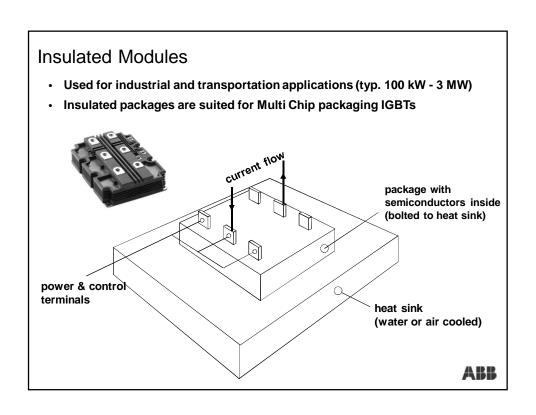
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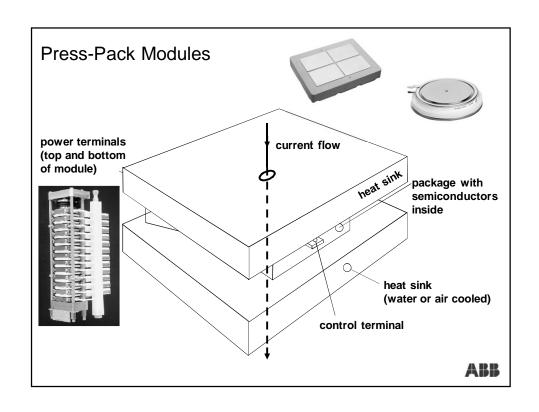
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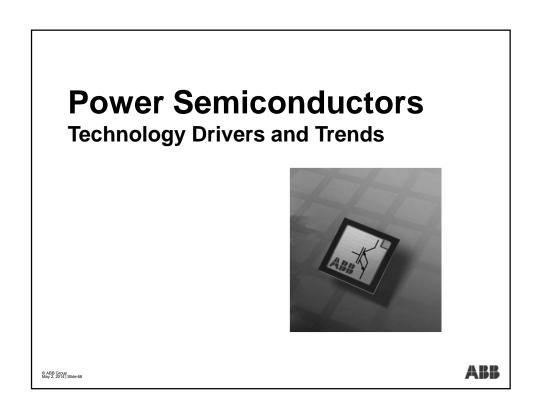
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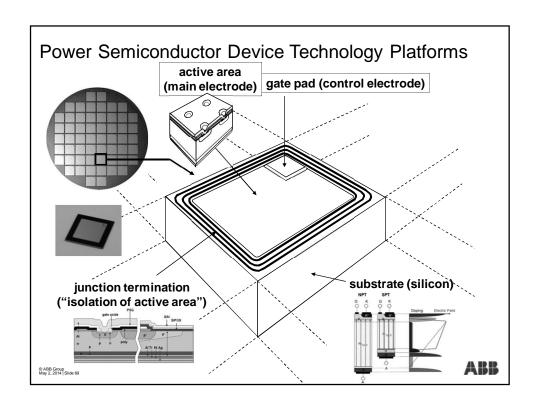
Power Semiconductor Device Packaging Concepts "Insulated" Devices **Press-Pack Devices** heat sink galvanically insulated heat sinks under high voltage Mounting from power terminals all devices of a system can be every device needs its own mounted on same heat sink **Failure Mode** open circuit after failure fails into low impedance state Industry Industry Markets Transportation Transportation T&D T&D Power range typically 100 kW - low MW MW transportation components have higher reliability demands

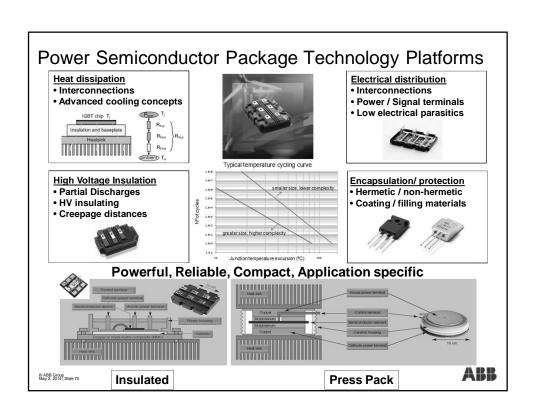


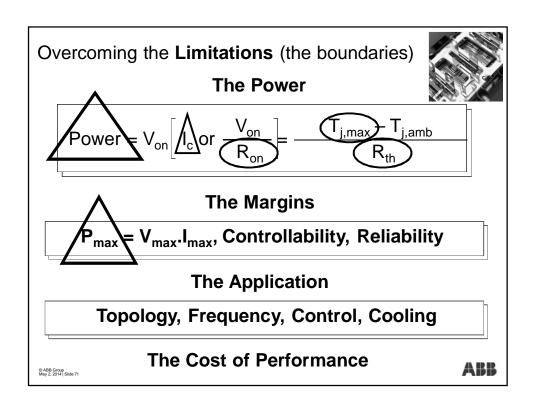


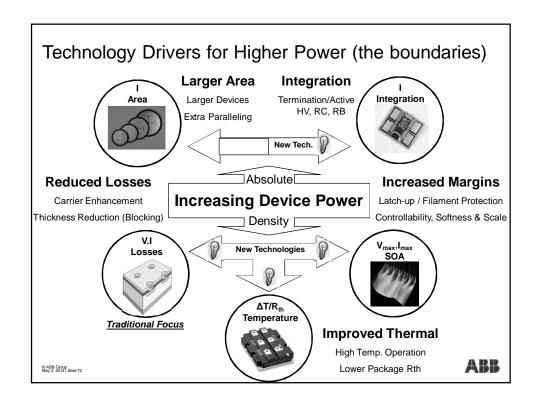


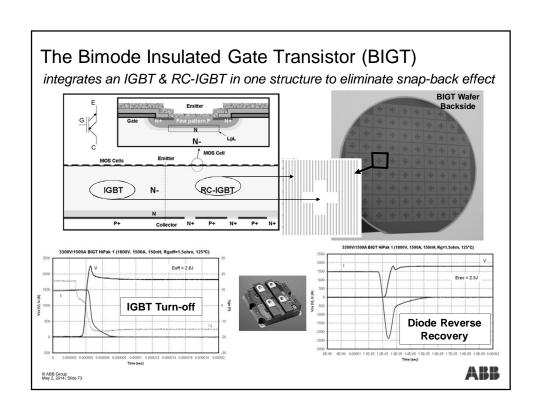


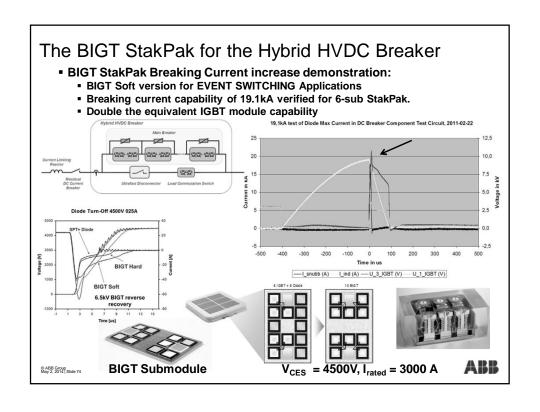




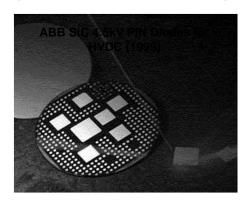








Wide Bandgap Technologies



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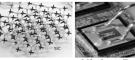
Wind Bandgap Semiconductors: Long Term Potentials

Parameter		Silicon	4H-SiC	GaN	Diamond
Band-gap E _g	eV	(1.12)	3.26	3.39	5.47
Critical Field Ecrit	MV/cm	0.23	(2.2)	3.3	5.6
Permitivity ε _r	_	11.8	9.7	9.0	5.7
Electron Mobility µ _n	cm ² /V·s	1400	950	800/1700*	1800
BFoM: ε _r ·μ _n ·E _{crit} ³	rel. to Si	1	500	1300/2700*	9000
Intrinsic Conc. ni	cm ⁻³	1.4·10 ¹⁰	8.2·10 ⁻⁹	1.9·10 ⁻¹⁰	1·10 ⁻²²
Thermal Cond. λ	W/cm·K	(1.5)	3.8	1.3/3**	20

* significant difference between bulk and 2DEG

** difference between epi and bulk

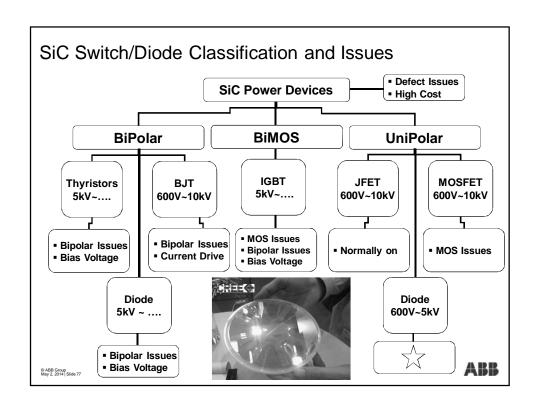
Comparison of R_m for Si, SiC, and GaN based

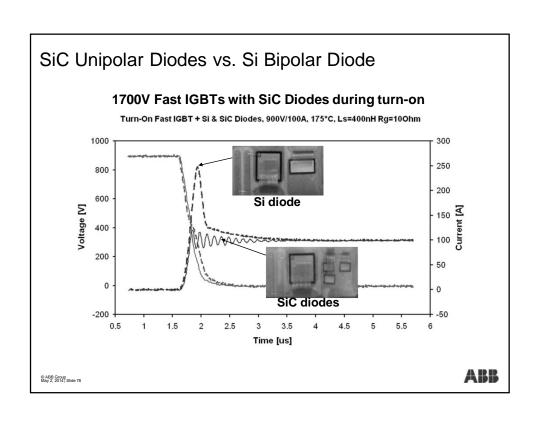


- Higher Blocking
- Lower Losses
- Lower Leakage
- But higher built-in voltage
- $\qquad \qquad \Box \rangle$
- Higher Power
- Wider Frequency Range
- Very High Voltages
- Higher Temperature

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Conclusions

- Si Based Power semiconductors are a key enabler for modern and future power electronics systems including grid systems
- · High power semiconductors devices and new system topologies are continuously improving for achieving higher power, improved efficiency and reliability and better controllability
- The Diode, PCT, IGCT, IGBT and MOSFET continue to evolve for achieving future system targets with the potential for improved power/performance through further losses reductions, higher operating temperatures and integration solutions
- Wide Band Gap Based Power Devices offer many performance advantages with strong potential for very high voltage applications



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